

IEC 62153-4-9

Edition 2.2 2024-06 CONSOLIDATED VERSION

# INTERNATIONAL STANDARD



Metallic communication cable test methods –
Part 4-9: Electromagnetic compatibility (EMC) related test method for measuring coupling attenuation of screened balanced cables – Triaxial method

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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## **METALLIC COMMUNICATION CABLE TEST METHODS -**

## Part 4-9: Electromagnetic compatibility (EMC) – Coupling attenuation of screened balanced cables, triaxial method

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This second edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- two test procedures, open head and standard head procedure;
- measuring with balun or with multiport respectively mixed mode VNA;
- extension of frequency range up to and above 2 GHz.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 62153 series can be found, under the general title *Metallic communication cable test methods*, on the IEC website.

The committee has decided that the contents of this document and its amendments will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

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## **INTRODUCTION** to Amendment 1

The goal of this amendment is to extent IEC 62153-4-9 such that also the coupling attenuation of unscreened single or multiple balanced pairs or unscreened quads can be measured with the triaxial test procedure.

Further complement is the extension of the usable frequency range down to frequencies below 9 kHz to measure the low frequency coupling attenuation of screened and unscreened balanced pairs or quads.

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## **METALLIC COMMUNICATION CABLE TEST METHODS -**

## Part 4-9: Electromagnetic compatibility (EMC) – Coupling attenuation of screened balanced cables, triaxial method

### 1 Scope

This part of IEC 62153 applies to metallic communication cables. It specifies a test method for determining the coupling attenuation  $a_{\rm C}$  of screened balanced cables. Due to the concentric outer tube, measurements are independent of irregularities on the circumference and external electromagnetic fields.

A wide dynamic and frequency range can be applied to test even super screened cables with normal instrumentation from low frequencies up to the limit of defined transversal waves in the outer circuit at approximately 4 GHz. However, when using a balun, the upper frequency is limited by the properties of the balun.

Measurements can be performed with standard tube procedure (respectively with standard test head) according to IEC 62153-4-4 or with open tube (open test head) procedure.

The procedure described herein to measure the coupling attenuation  $a_{\rm C}$  is based on the procedure to measure the screening attenuation  $a_{\rm S}$  according to IEC 62153-4-4.

### 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-726, International Electrotechnical Vocabulary – Chapter 726: Transmission lines and waveguides

IEC TS 62153-4-1, Metallic communication cable test methods – Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic screening measurements

IEC 62153-4-3, Metallic communication cable test methods – Part 4-3: Electromagnetic compatibility (EMC) – Surface transfer impedance – Triaxial method

IEC 62153-4-4, Metallic communication cable test methods – Part 4-4: Electromagnetic compatibility (EMC) – Test method for measuring of the screening attenuation as up to and above 3 GHz, triaxial method

IEC 62153-4-5, Metallic communication cables test methods – Part 4-5: Electromagnetic compatibility (EMC) – Coupling or screening attenuation – Absorbing clamp method

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IEC 62153-4-4, Metallic communication cable test methods – Part 4-4: Electromagnetic compatibility (EMC) – Test method for measuring of the screening attenuation as up to and above 3 GHz, triaxial method

IEC 62153-4-5, Metallic communication cables test methods – Part 4-5: Electromagnetic compatibility (EMC) – Coupling or screening attenuation – Absorbing clamp method